

December 2015

FDMD8580 Dual N-Channel PowerTrench<sup>®</sup> MOSFET

# FDMD8580 Dual N-Channel PowerTrench<sup>®</sup> MOSFET

# Q1: 80 V, 82 A, 4.6 mΩ Q2: 80 V, 82 A, 4.6 mΩ

### Features

### Q1: N-Channel

- Max r<sub>DS(on)</sub> = 4.6 mΩ at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 16 A
- Max r<sub>DS(on)</sub> = 6.0 mΩ at V<sub>GS</sub> = 8 V, I<sub>D</sub> = 14 A

Q2: N-Channel

- Max r<sub>DS(on)</sub> = 4.6 mΩ at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 16 A
- Max  $r_{DS(on)}$  = 6.0 m $\Omega$  at V<sub>GS</sub> = 8 V, I<sub>D</sub> = 14 A
- Ideal for Flexible Layout in Primary Side of Bridge Topology
- 100% UIL Tested
- Kelvin High Side MOSFET Drive Pin-out Capability
- RoHS Compliant



## **General Description**

This device includes two 80V N-Channel MOSFETs in a dual power (5 mm X 6 mm) package. HS source and LS drain internally connected for half/full bridge, low source inductance package, low  $r_{DS(on)}/Qg$  FOM silicon.

### Applications

- Synchronous Buck: Primary Switch of Half / Full Bridge Converter for Telecom
- Motor Bridge: Primary Switch of Half / Full Bridge Converter for BLDC Motor

S2

8 G2

D2/S1

6 D2/S1

5 D2/S1

7

MV POL: 48V Synchronous Buck Switch

G1

GR

D1

D1

2

3

4

Half/Full Bridge Secondary Synchronous Rectification

Top Bottom Pin 1 Pin 1 D2/S1 D2/S1 D2/S1 G2 D1 D1 GR G1 Pin 1 Pin 1



Symbol	Param		Q1	Q2	Units	
V <sub>DS</sub>	Drain to Source Voltage			80	80	V
V <sub>GS</sub>	Gate to Source Voltage			±20	±20	V
	Drain Current -Continuous	T <sub>C</sub> = 25 °C	(Note 5)	82	82	
	-Continuous	T <sub>C</sub> = 100 °C	(Note 5)	52	52	•
D	-Continuous	T <sub>A</sub> = 25 °C		16 <sup>1a</sup>	16 <sup>1b</sup>	A
	-Pulsed		(Note 4)	482	482	
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	337	337	mJ
	Power Dissipation	T <sub>C</sub> = 25 °C		59	59	10/
P <sub>D</sub>	Power Dissipation	T <sub>A</sub> = 25 °C		2.3 <sup>1a</sup>	2.3 <sup>1b</sup>	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range				+150	°C

### **Thermal Characteristics**

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction-to-Case	2.1	2.1	°C/W
$R_{ hetaJA}$	Thermal Resistance, Junction-to-Ambient	55 <sup>1a</sup>	55 <sup>1b</sup>	C/W

## Package Marking and Ordering Information

Devic	e Marking	Device	Package	Reel Size	Tape Width	Quantity
FDN	MD8580	FDMD8580	Power 5 x 6	13 "	12 mm	3000 units

FDMD8580 Dual N
<b>V</b> -Channe
l PowerTrench <sup>®</sup>
MOSFET

Symbol	Parameter	Test Conditions	Туре	Min.	Тур.	Max.	Units
Off Chai	racteristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_{D}$ = 250 $\mu$ A, V <sub>GS</sub> = 0 V	Q1 Q2	80 80			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25 °C	Q1 Q2		50 50		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 64 V, V <sub>GS</sub> = 0 V	Q1 Q2			1 1	μA
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V	Q1 Q2			±100 ±100	nA
On Char	acteristics						
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 250 \ \mu A$	Q1 Q2	2.0 2.0	3.4 3.4	4.5 4.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 µA, referenced to 25 °C	Q1 Q2		-10 -10		mV/°C
Ť		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 16 A			3.5	4.6	
		V <sub>GS</sub> = 8 V, I <sub>D</sub> = 14 A	Q1		4.2	6.0	mΩ
r	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 16 A, T <sub>J</sub> = 125 °C			5.3	7.0	
r <sub>DS(on)</sub>	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 16 A			3.5	4.6	
		V <sub>GS</sub> = 8 V, I <sub>D</sub> = 14 A	Q2		4.2	6.0	
		$V_{GS}$ = 10 V, I <sub>D</sub> = 16 A, T <sub>J</sub> = 125 °C	1		5.3	7.0	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DD</sub> = 10 V, I <sub>D</sub> = 16 A	Q1 Q2		51 51		S

**Electrical Characteristics** T<sub>J</sub> = 25 °C unless otherwise noted.

# **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance		Q1 Q2		4195 4195	5875 5875	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 40 V, V <sub>GS</sub> = 0 V f = 1 MHz	Q1 Q2		602 602	845 845	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		Q1 Q2		19 19	38 38	pF
R <sub>g</sub>	Gate Resistance		Q1 Q2	0.1 0.1	1.7 1.7	3.5 3.5	Ω

# **Switching Characteristics**

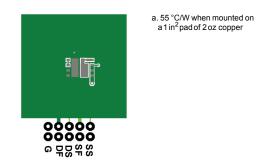
t <sub>d(on)</sub>	Turn-On Delay Time			Q1 Q2	25 25	40 40	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 40 V, I <sub>D</sub> = 16 A V <sub>GS</sub> = 10 V, R <sub>GEN</sub> = 6 Ω		Q1 Q2	19 19	34 34	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GS</sub> = 10 V, R <sub>GEN</sub> =	= 6 Ω	Q1 Q2	31 31	50 50	ns
t <sub>f</sub>	Fall Time			Q1 Q2	10 10	20 20	ns
Q <sub>g(TOT)</sub>	Total Gate Charge	$V_{GS}$ = 0 V to 10 V		Q1 Q2	57 57	80 80	nC
Q <sub>gs</sub>	Gate to Source Charge		V <sub>DD</sub> = 40 V, I <sub>D</sub> =16 A	Q1 Q2	21 21		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge			Q1 Q2	12 12		nC

FDMD8580 Dual N	
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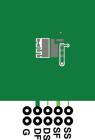
Symbol	Parameter	Test Conditions		Туре	Min.	Тур.	Max.	Units
Drain-S	ource Diode Characteristics							
	Source to Drain Diode Forward Voltage	$V_{} = 0 V_{} = 16 \Lambda$	(Note 2)	Q1		0.8	1.3	V
V <sub>SD</sub>	Source to Drain Diode Forward Voltage	$V_{\rm GS} = 0.0$ , $I_{\rm S} = 10$ A (Note 2)	Q2		0.8	1.3	v	
V	Source to Drain Diado Forward Voltage	$y_{1} = 0 y_{1} + 2 0$	(Note 2)	Q1		0.7	1.2	V
V <sub>SD</sub> Source to Drain Diode Forward Voltage		$V_{GS} = 0 V, I_S = 2 A$ (Note 2)	Q2		0.7	1.2	v	
+	Boyoroo Boooyooy Timo			Q1		46	73	
L <sub>rr</sub>	Reverse Recovery Time			Q2		46	73	ns
<u> </u>	Deverse Desever Charge	I <sub>F</sub> = 16 A, di/dt = 100 A/μs		Q1		34	55	-0
Q <sub>rr</sub>	Reverse Recovery Charge			Q2		34	55	nC

NOTES:

1.  $R_{\theta,JC}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta,JC}$  is guaranteed by design while  $R_{\theta,CA}$  is determined by the user's board design.

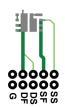




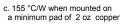


b. 55 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper

d. 155 °C/W when mounted on a minimum pad of 2 oz copper



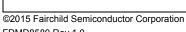
2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0 %.

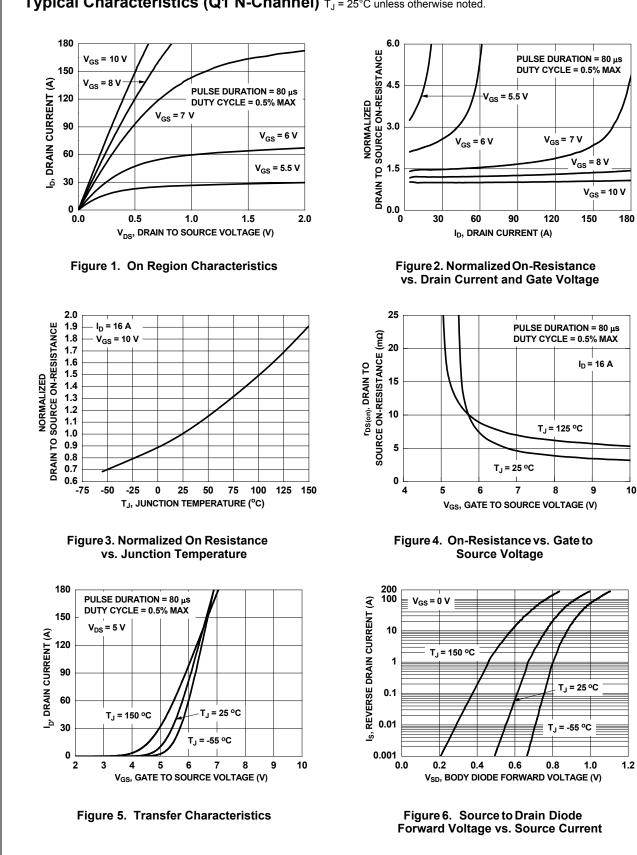


3. Q1:  $E_{AS}$  of 337 mJ is based on starting  $T_J = 25$  °C, L = 3 mH,  $I_{AS} = 15$  A,  $V_{DD} = 80$  V,  $V_{GS} = 10$  V. 100% tested at L = 0.1mH,  $I_{AS} = 49$  A. Q2:  $E_{AS}$  of 337 mJ is based on starting  $T_J = 25$  °C, L = 3 mH,  $I_{AS} = 15$  A,  $V_{DD} = 80$  V,  $V_{GS} = 10$  V. 100% tested at L = 0.1mH,  $I_{AS} = 49$  A. 4. Pulsed Id please refer to Fig 11 and Fig 24 SOA graph for more details.

5. Computed continuous current limited to max junction temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

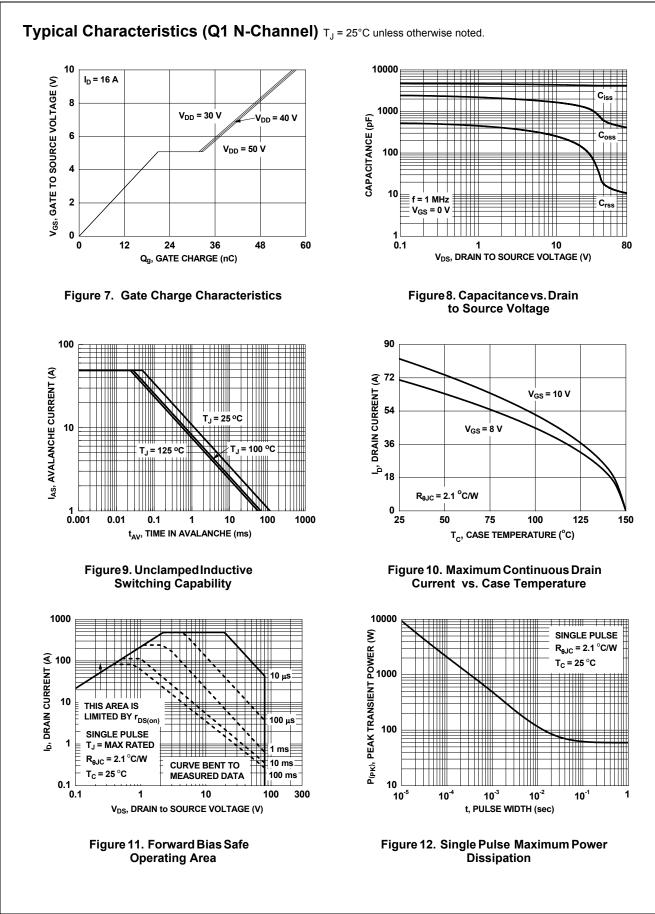


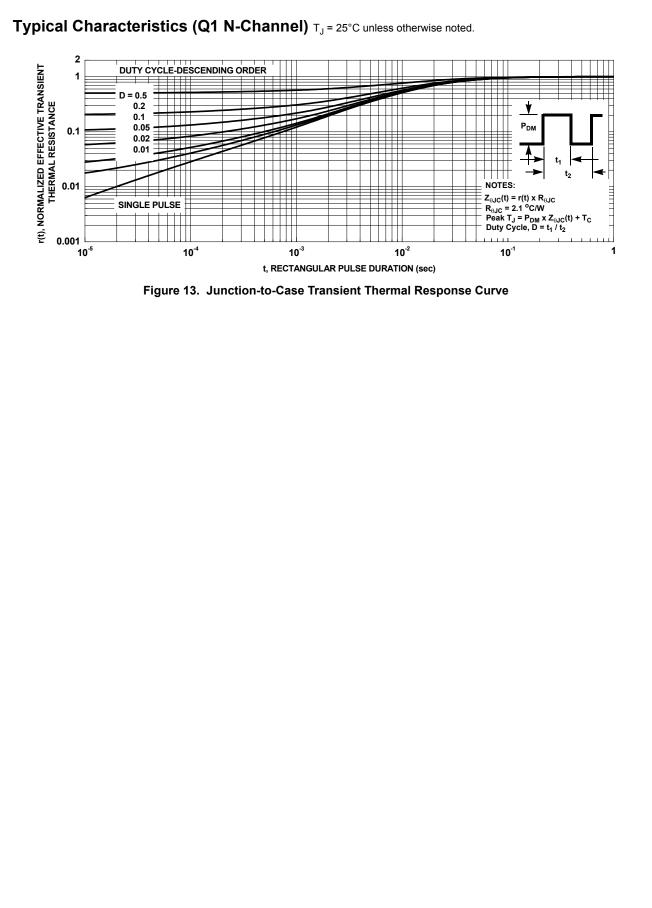


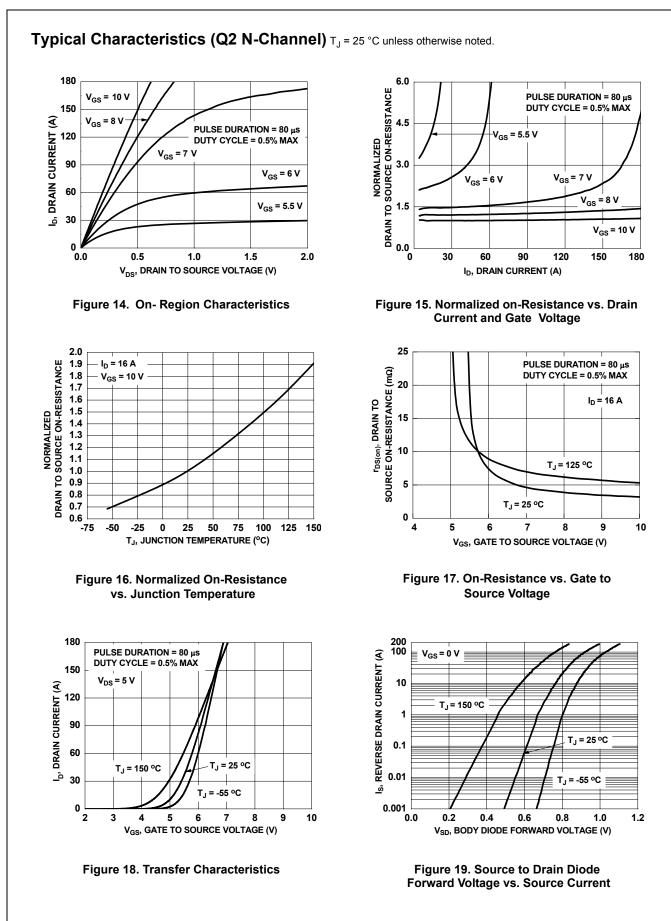


# Typical Characteristics (Q1 N-Channel) T<sub>J</sub> = 25°C unless otherwise noted.

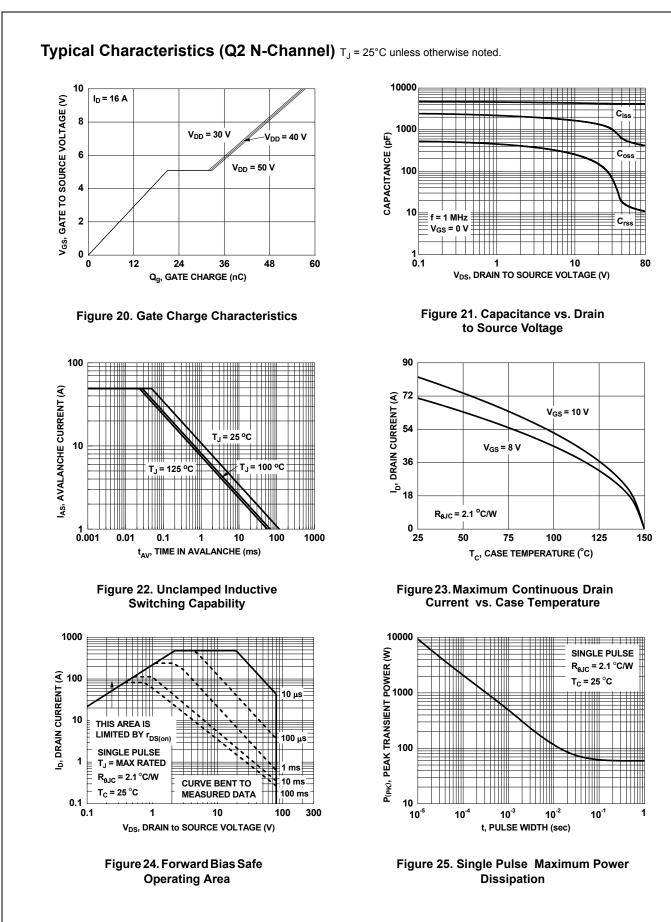




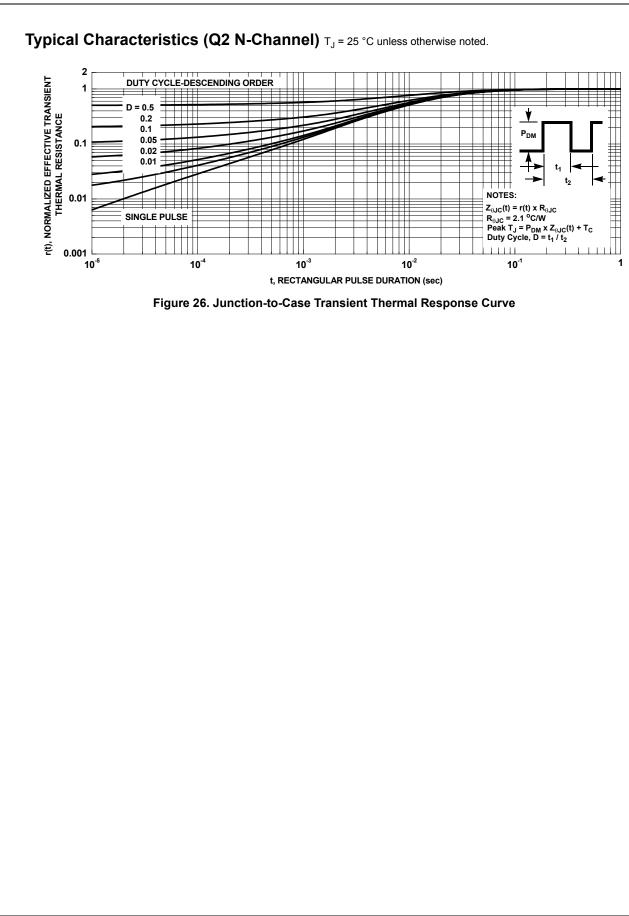


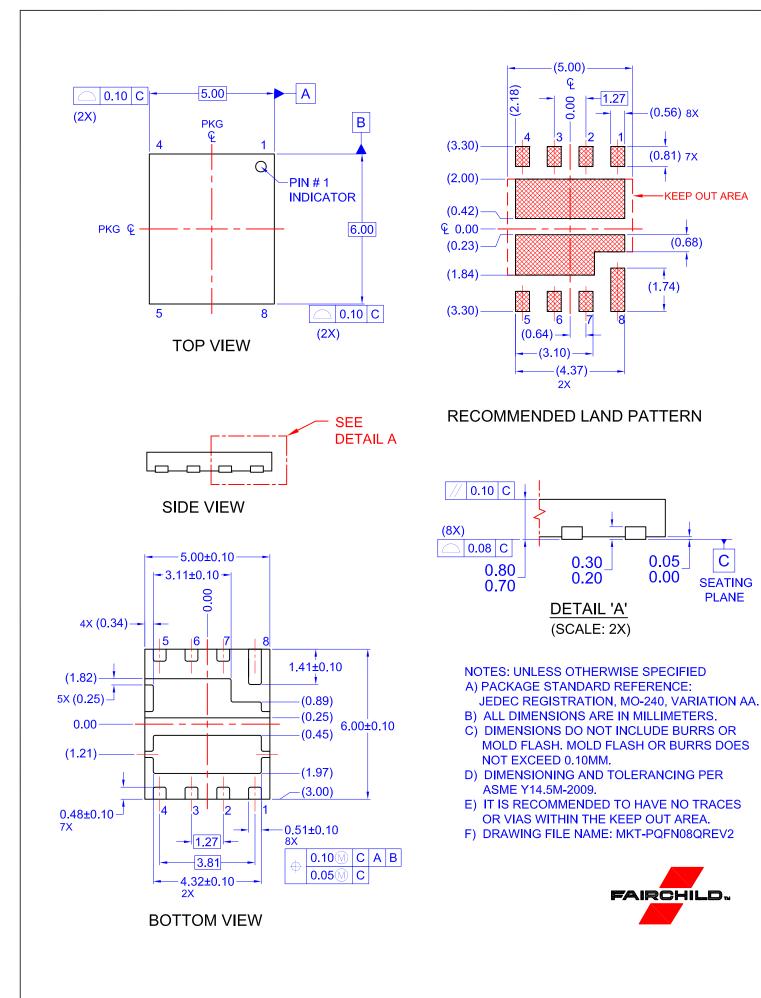


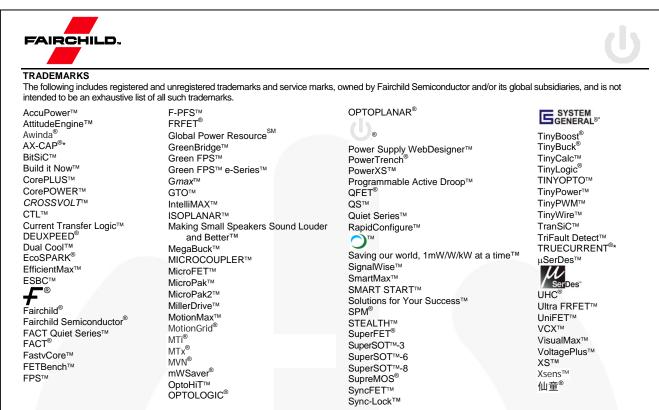












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